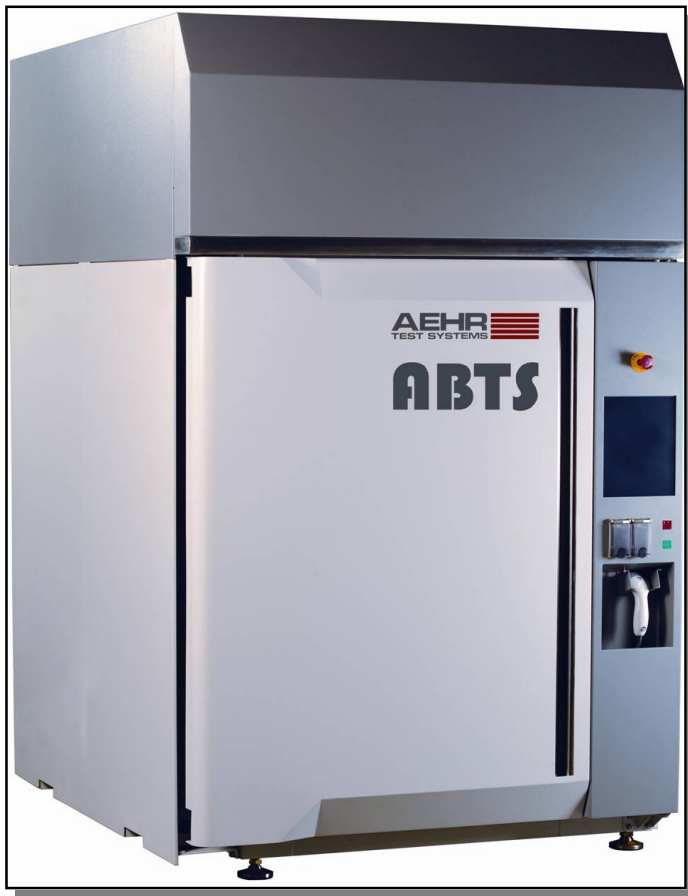


Advanced Burn-In & Test System

Cost-effective, reliable and highly configurable system engineered for burn-in and test of high power devices using sockets with independent thermal control



System Benefits:

- Addresses High Power Burn-In
 - ◆ Burn-in and test of high-power logic up to 100W
 - ◆ Fully integrated individual device temperature sensing, control, and reporting
 - ◆ Individual power supplies /DUT prevents burned sockets & BIB caused by shorted devices
- High Reliability and Uptime
 - ◆ Redundant architecture
 - ◆ Hot-swap electronics and power supplies
- Low Cost of Ownership
 - ◆ Up to 72 burn-in board slots
 - ◆ Small footprint
 - ◆ No side access required
 - ◆ Highly efficient power delivery
 - ◆ Low-power standby mode
- Highly Configurable for Production

“Changing the Way ICs Are Tested”

CORPORATE HEADQUARTERS
400 Kato Terrace
Fremont, CA 94539
Phone: (510) 623-9400
Fax: (510) 623-9450
Visit us at: www.aehr.com

